

# N-Channel Dual Cool<sup>TM</sup> 88 PowerTrench<sup>®</sup> MOSFET 80 V, 254 A, 1.35 m $\Omega$

# Features

- Max  $r_{DS(on)}$  = 1.35 m $\Omega$  at V<sub>GS</sub> = 10 V, I<sub>D</sub> = 36 A
- Max  $r_{DS(on)}$  = 1.82 m $\Omega$  at V<sub>GS</sub> = 8 V, I<sub>D</sub> = 31 A
- Advanced Package and Silicon combination for low r<sub>DS(on)</sub> and high efficiency
- Next generation enhanced body diode technology, engineered for soft recovery
- Low profile 8x8mm MLP package
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

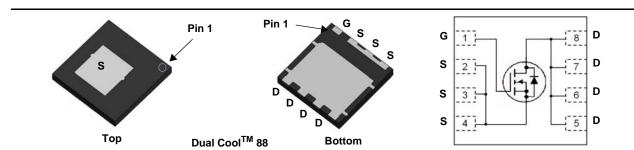


# **General Description**

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench<sup>®</sup> process. Advancements in both silicon and Dual Cool<sup>TM</sup> package technologies have been combined to offer the lowest  $r_{DS(on)}$  while maintaining excellent switching performance by extremely low Junction-to-Ambient thermal resistance.

# Applications

- OringFET / Load Switching
- Synchronous Rectification
- DC-DC Conversion





Symbol	Parameter			Ratings	Units	
V <sub>DS</sub>	Drain to Source Voltage			80	V	
V <sub>GS</sub>	Gate to Source Voltage			±20	V	
	Drain Current -Continuous	T <sub>C</sub> = 25 °C	(Note 5)	254		
	-Continuous	T <sub>C</sub> = 100 °C	(Note 5)	160	^	
D	-Continuous	T <sub>A</sub> = 25 °C	(Note 1a)	36	Α	
	-Pulsed		(Note 4)	1453		
E <sub>AS</sub>	Single Pulse Avalanche Energy (Note 3)			1734	mJ	
P <sub>D</sub>	Power Dissipation	T <sub>C</sub> = 25 °C		156	W	
	Power Dissipation	T <sub>A</sub> = 25 °C	(Note 1a)	3.2	vv	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range			-55 to +150	°C	

## **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Top Source)	1.6	
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case	(Bottom Drain)	0.8	
$R_{\thetaJA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	38	
$R_{\thetaJA}$	Thermal Resistance, Junction-to-Ambient	(Note 1b)	81	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1i)	15	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1j)	21	
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1k)	9	

## Package Marking and Ordering Information

Γ	Device Marking	Device	Package	Reel Size	Tape Width	Quantity
	80080DC	FDMT80080DC	Dual Cool <sup>TM</sup> 88	13"	13.3 mm	3000 units

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Symbol	Parameter	Test Con	ditions	Min.	Тур.	Max.	Units
Off Chara	octeristics						
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 250 μA, V <sub>GS</sub> =	0 V	80			V
$\Delta BV_{DSS} \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu A$ , referen	nced to 25 °C		41		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 64 \text{ V}, \text{ V}_{GS} =$	0 V			1	μA
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, \text{ V}_{DS} =$	= 0 V			100	nA
On Chara	cteristics						
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250$	) μΑ	2.0	3.1	4.0	V
$\Delta V_{GS(th)}$ $\Delta T_J$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referen			-12		mV/°C
	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 36 A		A		1.06	1.35	mΩ
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 8 V, I <sub>D</sub> = 31 A			1.23	1.82	
		$V_{GS}$ = 10 V, I <sub>D</sub> = 36 A, T <sub>J</sub> = 125 °C			1.74	2.22	
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 36 A			116		S
Dynamic C <sub>iss</sub>	Characteristics Input Capacitance	V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V, f = 1 MHz			14800	20720	pF
C <sub>oss</sub>	Output Capacitance				2080	2915	pF
C <sub>rss</sub>	Reverse Transfer Capacitance				56	125	pF
R <sub>g</sub>	Gate Resistance			0.1	1.8	4.5	Ω
Switching	Characteristics						
t <sub>d(on)</sub>	Turn-On Delay Time				67	108	ns
t <sub>r</sub>	Rise Time	$V_{DD}$ = 40 V, I <sub>D</sub> = 36 A, V <sub>GS</sub> = 10 V, R <sub>GEN</sub> = 6 Ω			65	104	ns
t <sub>d(off)</sub>	Turn-Off Delay Time				75	120	ns
t <sub>f</sub>	Fall Time		-		30	48	ns
Q <sub>q(TOT)</sub>	Total Gate Charge	$V_{GS} = 0 V$ to 10 V			195	273	nC
Q <sub>q(TOT)</sub>	Total Gate Charge	$V_{GS} = 0 V \text{ to } 8 V$	V <sub>DD</sub> = 40 V,		159	223	nC
Q <sub>gs</sub>	Gate to Source Charge	I <sub>D</sub> = 36 A			69		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge				36		nC
Drain-Sou	urce Diode Characteristics						
		$V_{CS} = 0 V_{.} I_{S} = 2.6 A$			0.7	1.1	
V <sub>SD</sub>	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 36 A$			0.8	1.2	V
t <sub>rr</sub>	Reverse Recovery Time				81	130	ns
		—I <sub>F</sub> = 36 A, di/dt = 100 A/μs					

Therma	I Characteristics			
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction-to-Case	(Top Source)	1.6	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Bottom Drain)	0.8	
$R_{\thetaJA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	38	
$R_{\thetaJA}$	Thermal Resistance, Junction-to-Ambient	(Note 1b)	81	
$R_{\thetaJA}$	Thermal Resistance, Junction-to-Ambient	(Note 1c)	26	
$R_{\thetaJA}$	Thermal Resistance, Junction-to-Ambient	(Note 1d)	34	
$R_{\thetaJA}$	Thermal Resistance, Junction-to-Ambient	(Note 1e)	14	°C/W
$R_{\thetaJA}$	Thermal Resistance, Junction-to-Ambient	(Note 1f)	16	°C/VV
$R_{\thetaJA}$	Thermal Resistance, Junction-to-Ambient	(Note 1g)	26	
$R_{\thetaJA}$	Thermal Resistance, Junction-to-Ambient	(Note 1h)	60	
$R_{\thetaJA}$	Thermal Resistance, Junction-to-Ambient	(Note 1i)	15	
$R_{\thetaJA}$	Thermal Resistance, Junction-to-Ambient	(Note 1j)	21	
$R_{\thetaJA}$	Thermal Resistance, Junction-to-Ambient	(Note 1k)	9	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1I)	11	

NOTES:

1. R<sub>0JA</sub> is determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. R<sub>0CA</sub> is determined by the user's board design.



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c. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in  $^2\,\text{pad}$  of 2 oz copper

d. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper

- e. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- f. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper

a. 38 °C/W when mounted on

a 1 in<sup>2</sup> pad of 2 oz copper

- g. 200FPM Airflow, No Heat Sink,1 in<sup>2</sup> pad of 2 oz copper
- h. 200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper

i. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper

- j. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper
- k. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- I. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper

2. Pulse Test: Pulse Width < 300  $\mu s,$  Duty cycle < 2.0%.

3. E<sub>AS</sub> of 1734 mJ is based on starting T<sub>J</sub> = 25  $^{\circ}$ C; N-ch: L = 3 mH, I<sub>AS</sub> = 34 A, V<sub>DD</sub> = 80 V, V<sub>GS</sub> =10 V. 100% test at L = 0.3 mH, I<sub>AS</sub> = 75 A.

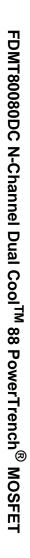
4. Pulsed Id please refer to Fig 11 SOA graph for more details.

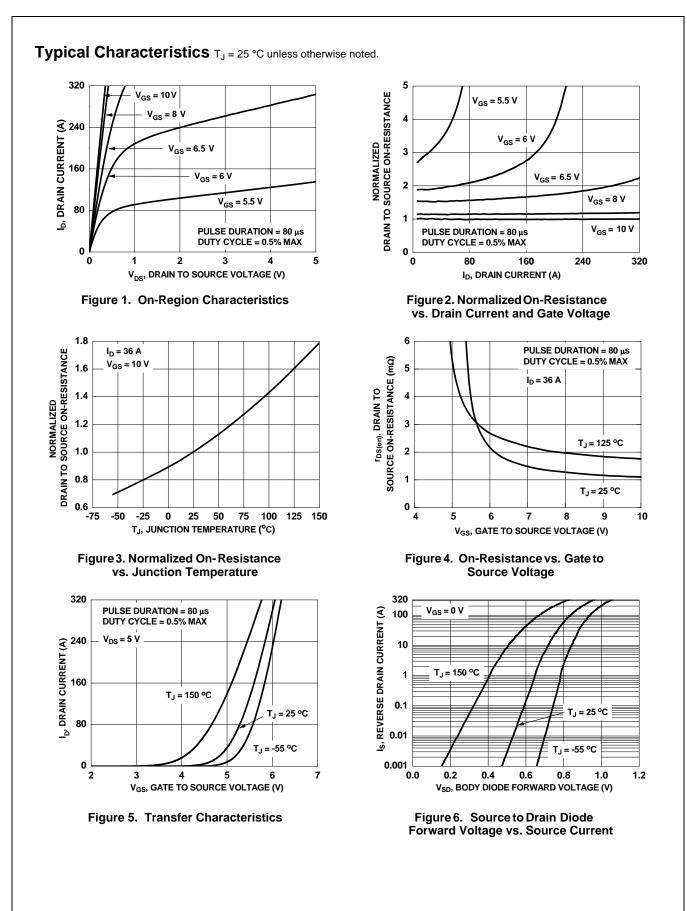
5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

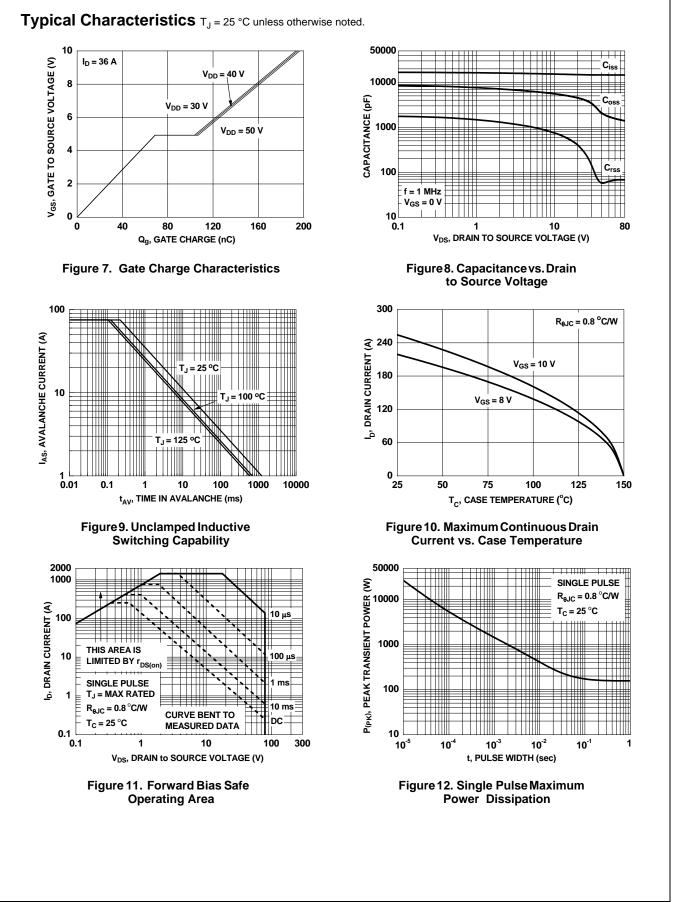
b. 81 °C/W when mounted on

GSSPD

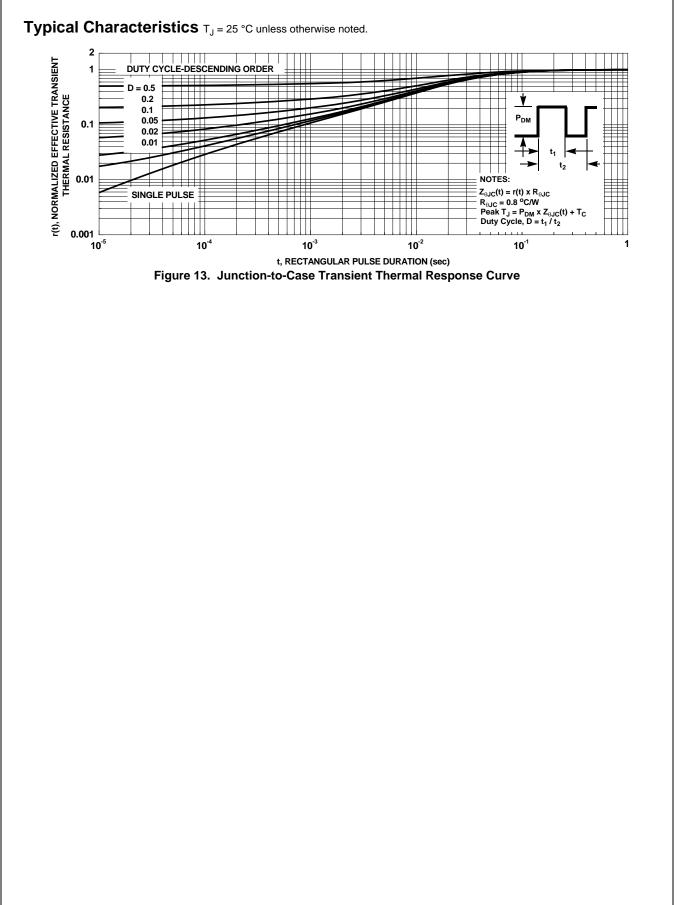
a minimum pad of 2 oz copper

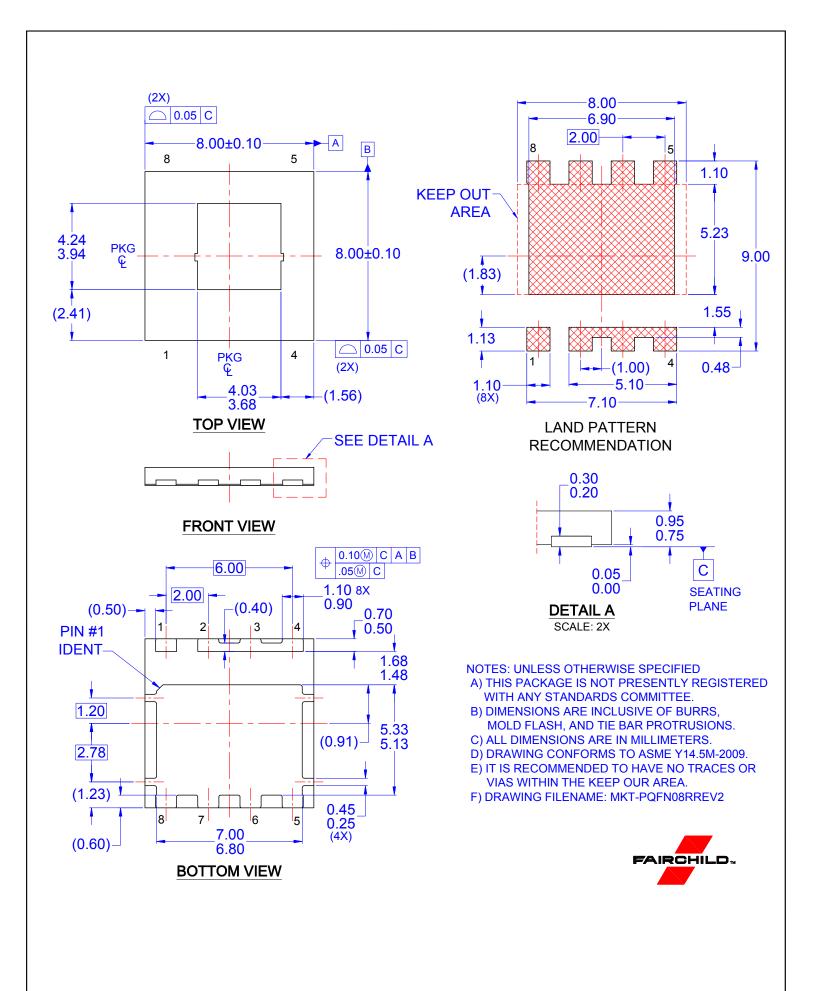






FDMT80080DC N-Channel Dual Cool<sup>TM</sup> 88 PowerTrench<sup>®</sup> MOSFET







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